

Notice of References Cited	Application/Control No. 14/451,531	Applicant(s)/Patent Under Reexamination WISER ET AL.	
	Examiner SONJI TURNER	Art Unit 1776	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	CPC Classification	US Classification
*	A	US-6,514,324 B1	02-2003	Chapman; Rick L.	B03C3/28	264/484
*	B	US-2004/0140194 A1	07-2004	Taylor, Roy M. JR.	A61L9/014	204/164
*	C	US-6,805,732 B1	10-2004	Billiotte; Jean-Marie	A61L9/22	264/129
*	D	US-6,955,708 B1	10-2005	Julos; John J.	B03C3/011	422/121
*	E	US-2006/0137527 A1	06-2006	Joannou; ConstantinosJ	B03C3/60	96/66
*	F	US-7,150,780 B2	12-2006	Krichtafovitch; Igor A.	B03C3/08	250/423R
*	G	US-7,258,729 B1	08-2007	Barsimanto; Albert	B03C3/09	96/226
*	H	US-7,323,146 B2	01-2008	Kim; Young-Saeng	A61L9/16	422/121
*	I	US-8,252,095 B2	08-2012	Wiser; Forwood C.	B03C3/30	55/528
	J	US-				
	K	US-				
	L	US-				
	M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	CPC Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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